


<b>Search Notes</b>  	<b>Application/Control No.</b>  09993930	<b>Applicant(s)/Patent Under Reexamination</b>  FLICK, KENNETH E.
	<b>Examiner</b>  Nam V Nguyen	<b>Art Unit</b>  2612

SEARCHED			
Class	Subclass	Date	Examiner
340	5.22, 5.23-5.28; 5.3-5.32; 5.7-5.74; 7.51-7.59	2/1/10	NN

SEARCH NOTES		
Search Notes	Date	Examiner
Search EAST: USPAT; US PUB; EPO; JPO; and Derwent. (updated from previous search).	2/1/10	NN
Search Terms: learned/trained program code; switch back to normal mode; indicator/indicating; switching mode with indicator	2/1/10	NN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
SAME AS	ABOVE	2/1/10	NN

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